2M x 32Bit x 4 Banks Mobile SDRAM in 90FBGA

FEATURES

- 3.0V & 3.3V power supply.
- LVCMOS compatible with multiplexed address.
- Four banks operation.
- MRS cycle with address key programs.
  - -. CAS latency (1, 2 & 3).
  - -. Burst length (1, 2, 4, 8 & Full page).
  - -. Burst type (Sequential & Interleave).
- EMRS cycle with address key programs.
- All inputs are sampled at the positive going edge of the system clock.
- Burst read single-bit write operation.
- Special Function Support.
  - -. PASR (Partial Array Self Refresh).
  - -. Internal TCSR (Temperature Compensated Self Refresh)
- DQM for masking.
- Auto refresh.
- 64ms refresh period (4K cycle).
- Commercial Temperature Operation (-25°C ~ 70°C).
- Extended Temperature Operation (-25°C ~ 85°C).
- 90Balls FBGA (-FXXX -Pb, -HXXX -Pb Free).

GENERAL DESCRIPTION

The K4S563233F is 268,435,456 bits synchronous high data rate Dynamic RAM organized as 4 x 2,097,152 words by 32 bits, fabricated with SAMSUNG's high performance CMOS technology. Synchronous design allows precise cycle control with the use of system clock and I/O transactions are possible on every clock cycle. Range of operating frequencies, programmable burst lengths and programmable latencies allow the same device to be useful for a variety of high bandwidth and high performance memory system applications.

ORDERING INFORMATION

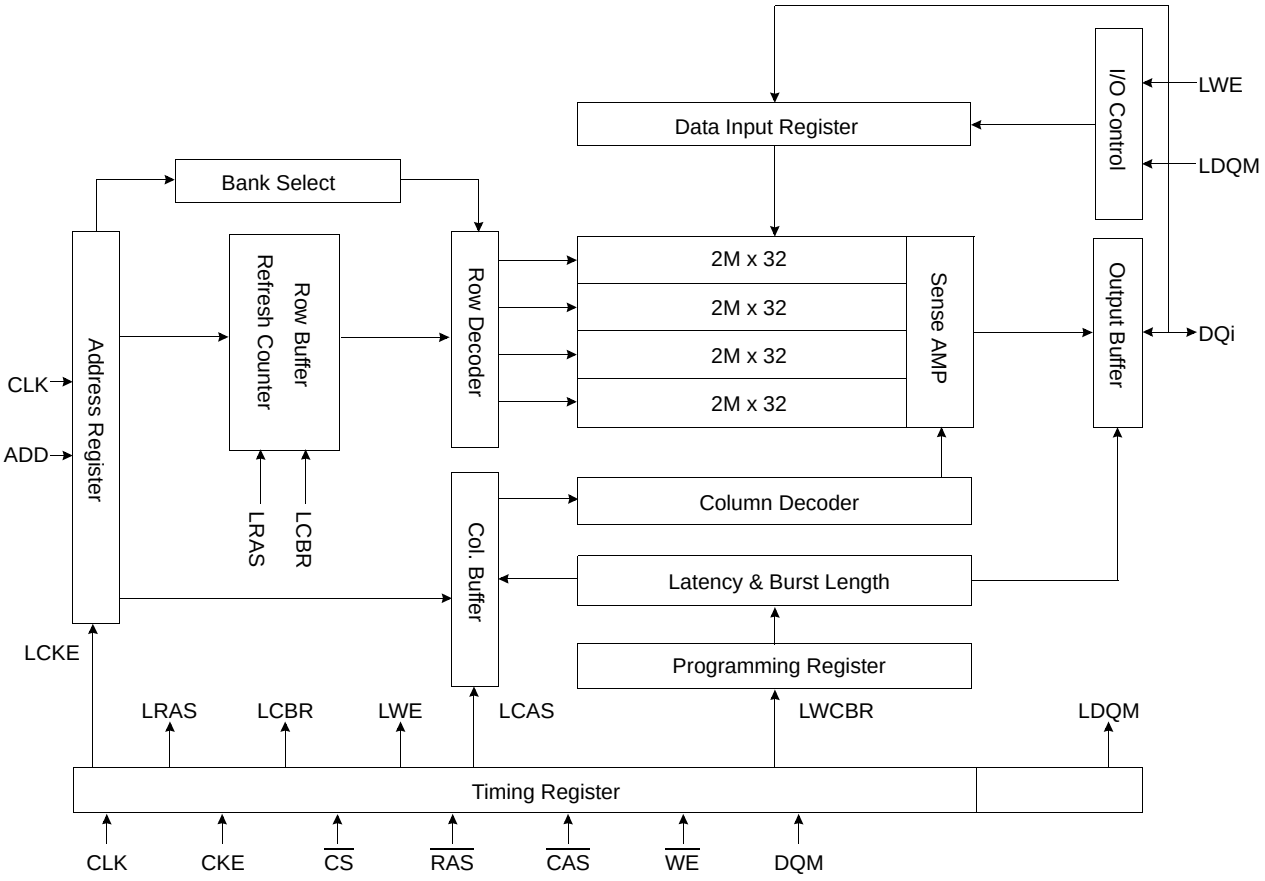
Part No.	Max Freq.	Interface	Package
K4S563233F-F(H)E/N/G/C/L/F60	166MHz(CL=3)	LVCMOS	90 FBGA Pb (Pb Free)
K4S563233F-F(H)E/N/G/C/L/F75	133MHz(CL=3),111MHz(CL=2)		
K4S563233F-F(H)E/N/G/C/L/F1H	111MHz(CL=2)		
K4S563233F-F(H)E/N/G/C/L/F1L	111MHz(CL=3)*1		

- F(H)E/N/G : Normal/Low/Super Low Power, Extended Temperature(-25°C ~ 85°C)
- F(H)C/L/F : Normal/Low/Super Low Power, Commercial Temperature(-25°C ~ 70°C)

NOTES :

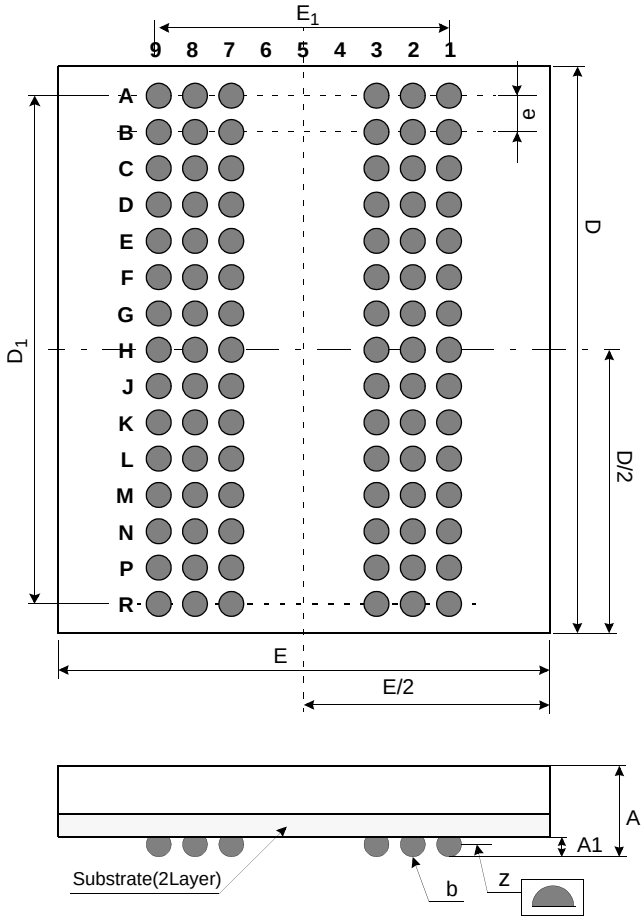
1. In case of 40MHz Frequency, CL1 can be supported.
2. Samsung are not designed or manufactured for use in a device or system that is used under circumstance in which human life is potentially at stake. Please contact to the memory marketing team in samsung electronics when considering the use of a product contained herein for any specific pur pose, such as medical, aerospace, nuclear, military, vehicular or undersea repeater use.

FUNCTIONAL BLOCK DIAGRAM



Package Dimension and Pin Configuration

< Bottom View*1 >



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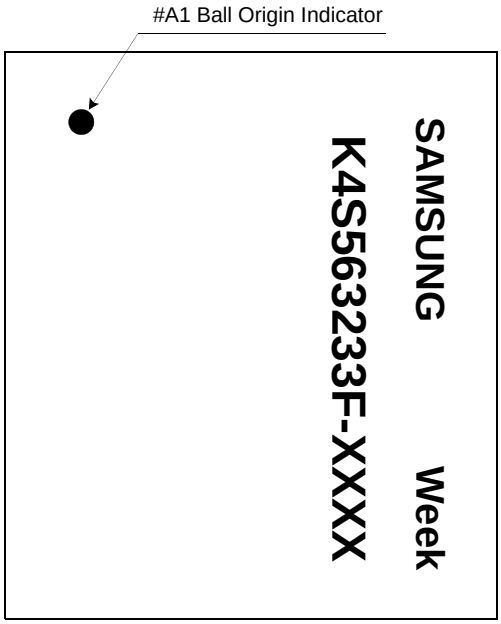


< Top View*2 >

90Ball(6x15) FBGA						
	1	2	3	7	8	9
A	DQ26	DQ24	V_{SS}	V_{DD}	DQ23	DQ21
B	DQ28	V_{DDQ}	V_{SSQ}	V_{DDQ}	V_{SSQ}	DQ19
C	V_{SSQ}	DQ27	DQ25	DQ22	DQ20	V_{DDQ}
D	V_{SSQ}	DQ29	DQ30	DQ17	DQ18	V_{DDQ}
E	V_{DDQ}	DQ31	NC	NC	DQ16	V_{SSQ}
F	V_{SS}	DQM3	A3	A2	DQM2	V_{DD}
G	A4	A5	A6	A10	A0	A1
H	A7	A8	NC	NC	BA1	A11
J	CLK	CKE	A9	BA0	$\overline{CS}$	$\overline{RAS}$
K	DQM1	NC	NC	$\overline{CAS}$	$\overline{WE}$	DQM0
L	V_{DDQ}	DQ8	V_{SS}	V_{DD}	DQ7	V_{SSQ}
M	V_{SSQ}	DQ10	DQ9	DQ6	DQ5	V_{DDQ}
N	V_{SSQ}	DQ12	DQ14	DQ1	DQ3	V_{DDQ}
P	DQ11	V_{DDQ}	V_{SSQ}	V_{DDQ}	V_{SSQ}	DQ4
R	DQ13	DQ15	V_{SS}	V_{DD}	DQ0	DQ2

Pin Name	Pin Function
CLK	*System Clock*
$\overline{CS}$	*Chip Select*
CKE	*Clock Enable*
A_0 ~ A_{11}	*Address*
BA_0 ~ BA_1	*Bank Select Address*
$\overline{RAS}$	*Row Address Strobe*
$\overline{CAS}$	*Column Address Strobe*
$\overline{WE}$	*Write Enable*
DQM_0 ~ DQM_3	*Data Input/Output Mask*
DQ_0 ~ $_{31}$	*Data Input/Output*
V_{DD}/V_{SS}	*Power Supply/Ground*
V_{DDQ}/V_{SSQ}	*Data Output Power/Ground*

[Unit:mm]

Symbol	Min	Typ	Max
A	-	1.10	1.20
A_1	0.27	0.32	0.37
E	-	8.00	-
E_1	-	6.40	-
D	-	13.00	-
D_1	-	11.20	-
e	-	0.80	-
b	0.45	0.50	0.55
z	-	-	0.10

ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Voltage on any pin relative to V_{SS}	V_{IN}, V_{OUT}	-1.0 ~ 4.6	V
Voltage on V_{DD} supply relative to V_{SS}	V_{DD}, V_{DDQ}	-1.0 ~ 4.6	V
Storage temperature	T_{STG}	-55 ~ +150	°C
Power dissipation	P_D	1.0	W
Short circuit current	I_{OS}	50	mA

NOTES:
Permanent device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded.
Functional operation should be restricted to recommended operating condition.
Exposure to higher than recommended voltage for extended periods of time could affect device reliability.

DC OPERATING CONDITIONS

Recommended operating conditions (Voltage referenced to V_{SS} = 0V, T_A = -25 to 85°C for Extended, -25 to 70°C for Commercial)

Parameter	Symbol	Min	Typ	Max	Unit	Note
Supply voltage	V_{DD}	2.7	3.0	3.6	V	
	V_{DDQ}	2.7	3.0	3.6	V	
Input logic high voltage	V_{IH}	2.2	3.0	V_{DDQ} + 0.3	V	1
Input logic low voltage	V_{IL}	-0.3	0	0.5	V	2
Output logic high voltage	V_{OH}	2.4	-	-	V	I_{OH} = -2mA
Output logic low voltage	V_{OL}	-	-	0.4	V	I_{OL} = 2mA
Input leakage current	I_{LI}	-10	-	10	uA	3

NOTES :
1. VIH (max) = 5.3V AC.The overshoot voltage duration is ≤ 3ns.
2. VIL (min) = -2.0V AC. The undershoot voltage duration is ≤ 3ns.
3. Any input 0V ≤ VIN ≤ VDDQ.
   Input leakage currents include Hi-Z output leakage for all bi-directional buffers with tri-state outputs.
4. Dout is disabled, 0V ≤ VOUT ≤ VDDQ.

CAPACITANCE (V_{DD} = 3.0V & 3.3V, T_A = 23°C, f = 1MHz, V_{REF} =0.9V ± 50 mV)

Pin	Symbol	Min	Max	Unit	Note
Clock	C_{CLK}	-	4.0	pF	
$\overline{RAS}$, $\overline{CAS}$, $\overline{WE}$, $\overline{CS}$, CKE	C_{IN}	-	4.0	pF	
DQM	C_{IN}	-	4.0	pF	
Address	C_{ADD}	-	4.0	pF	
DQ_0 ~ DQ_{31}	C_{OUT}	-	6.0	pF	

DC CHARACTERISTICS

Recommended operating conditions (Voltage referenced to V_{SS} = 0V, T_A = -25 to 85°C for Extended, -25 to 70°C for Commercial)

Parameter	Symbol	Test Condition	Version				Unit	Note
			-60	-75	-1H	-1L		
Operating Current (One Bank Active)	I_{CC1}	Burst length = 1 $t_{RC} \geq t_{RC}$(min) I_O = 0 mA	110	100	100	90	mA	1
Precharge Standby Current in power-down mode	I_{CC2P}	CKE ≤ V_{IL}(max), t_{CC} = 10ns	0.5				mA	
	I_{CC2PS}	CKE & CLK ≤ V_{IL}(max), t_{CC} = ∞	0.5					
Precharge Standby Current in non power-down mode	I_{CC2N}	CKE ≥ V_{IH}(min), $\overline{CS}$ ≥ V_{IH}(min), t_{CC} = 10ns Input signals are changed one time during 20ns	20				mA	
	I_{CC2NS}	CKE ≥ V_{IH}(min), CLK ≤ V_{IL}(max), t_{CC} = ∞ Input signals are stable	8					
Active Standby Current in power-down mode	I_{CC3P}	CKE ≤ V_{IL}(max), t_{CC} = 10ns	4				mA	
	I_{CC3PS}	CKE & CLK ≤ V_{IL}(max), t_{CC} = ∞	2					
Active Standby Current in non power-down mode (One Bank Active)	I_{CC3N}	CKE ≥ V_{IH}(min), $\overline{CS}$ ≥ V_{IH}(min), t_{CC} = 10ns Input signals are changed one time during 20ns	30				mA	
	I_{CC3NS}	CKE ≥ V_{IH}(min), CLK ≤ V_{IL}(max), t_{CC} = ∞ Input signals are stable	20				mA	
Operating Current (Burst Mode)	I_{CC4}	I_O = 0 mA Page burst 4Banks Activated t_{CCD} = 2CLKs	120	100	90	90	mA	1
Refresh Current	I_{CC5}	$t_{RC} \geq t_{RC}$(min)	200	180	170	150	mA	2
Self Refresh Current	I_{CC6}	CKE ≤ 0.2V	**-E/C**		1500		uA	4
			-N/L		600			5
			-G/F	**Internal TCSR**	**Max 40**	**Max 85/70**	**°C**	3
				Full Array	450	600	uA	6
				1/2 of Full	400	450		
				1/4 of Full	350	400		

NOTES:

1. Measured with outputs open.
2. Refresh period is 64ms.
3. Internal TCSR can be supported.
   In commercial Temp : Max 40°C/Max 70°C, In extended Temp : Max 40°C/Max 85°C
4. K4S563233F-F(H)E/C**
5. K4S563233F-F(H)N/L**
6. K4S563233F-F(H)G/F**
7. Unless otherwise noted, input swing level is CMOS(VIH /VIL=VDDQ/VSSQ).

AC OPERATING TEST CONDITIONS (V_{DD} = 2.7V ~ 3.6V, T_A = -25 to 85°C for Extended, -25 to 70°C for Commercial)

Parameter	Value	Unit
AC input levels (Vih/Vil)	2.4 / 0.4	V
Input timing measurement reference level	1.4	V
Input rise and fall time	tr/tf = 1/1	ns
Output timing measurement reference level	1.4	V
Output load condition	See Figure 2	

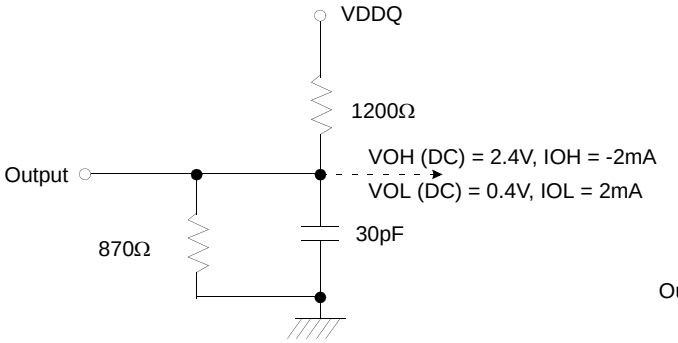


Figure 1. DC Output Load Circuit

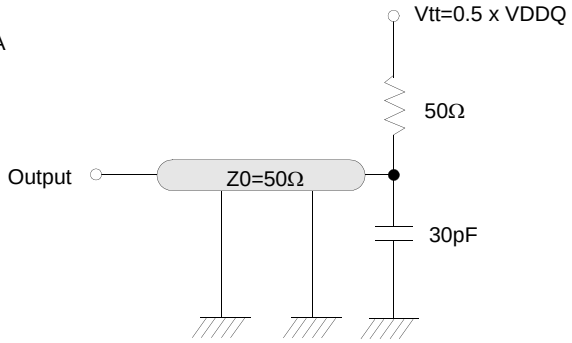


Figure 2. AC Output Load Circuit

OPERATING AC PARAMETER

(AC operating conditions unless otherwise noted)

Parameter		Symbol	Version				Unit	Note
			-60	-75	-1H	-1L		
Row active to row active delay		tRRD(min)	12	15	18	18	ns	1
$\overline{RAS}$ to $\overline{CAS}$ delay		tRCD(min)	18	18	18	24	ns	1
Row precharge time		tRP(min)	18	18	18	24	ns	1
Row active time		tRAS(min)	42	45	50	60	ns	1
		tRAS(max)	100				us	
Row cycle time		tRC(min)	60	63	68	84	ns	1
Last data in to row precharge		tRDL(min)	2				CLK	2
Last data in to Active delay		tDAL(min)	tRDL + tRP				-	3
Last data in to new col. address delay		tCDL(min)	1				CLK	2
Last data in to burst stop		tBDL(min)	1				CLK	2
Col. address to col. address delay		tCCD(min)	1				CLK	4
Number of valid output data	CAS latency=3		2				ea	5
Number of valid output data	CAS latency=2		-	1				
Number of valid output data	CAS latency=1		-			0		

NOTES:

1. The minimum number of clock cycles is determined by dividing the minimum time required with clock cycle time and then rounding off to the next higher integer.
2. Minimum delay is required to complete write.
3. Minimum tRDL=2CLK and tDAL(= tRDL + tRP) is required to complete both of last data write command(tRDL) and precharge command(tRP).
4. All parts allow every cycle column address change.
5. In case of row precharge interrupt, auto precharge and read burst stop.

AC CHARACTERISTICS(AC operating conditions unless otherwise noted)

Parameter		Symbol	- 60		- 75		-1H		-1L		Unit	Note
			Min	Max	Min	Max	Min	Max	Min	Max		
CLK cycle time	CAS latency=3	tCC	6.0	1000	7.5	1000	9.0	1000	9.0	1000	ns	1
	CAS latency=2	tCC	-		9.0		9.0		12			
	CAS latency=1	tCC	-		-		-		25			
CLK to valid output delay	CAS latency=3	tSAC		5.4		6		7		7	ns	1,2
	CAS latency=2	tSAC		-		7		7		8		
	CAS latency=1	tSAC		-		-		-		20		
Output data hold time	CAS latency=3	tOH	2.5		2.5		2.5		2.5		ns	2
	CAS latency=2	tOH	-		2.5		2.5		2.5			
	CAS latency=1	tOH	-		-		-		2.5			
CLK high pulse width		tCH	2.5		2.5		3		3		ns	3
CLK low pulse width		tCL	2.5		2.5		3		3		ns	3
Input setup time		tSS	2.0		2.0		2.5		2.5		ns	3
Input hold time		tSH	1.0		1.0		1.5		1.5		ns	3
CLK to output in Low-Z		tSLZ	1		1		1		1		ns	2
CLK to output in Hi-Z	CAS latency=3	tSHZ		5.4		6		7		7	ns	
	CAS latency=2			-		7		7		8		
	CAS latency=1			-		-		-		20		

NOTES :

1. Parameters depend on programmed CAS latency.
2. If clock rising time is longer than 1ns, (tr/2-0.5)ns should be added to the parameter.
3. Assumed input rise and fall time (tr & tf) = 1ns.
   If tr & tf is longer than 1ns, transient time compensation should be considered,
   i.e., [(tr + tf)/2-1]ns should be added to the parameter.

SIMPLIFIED TRUTH TABLE

COMMAND			CKEn-1	CKEn	$\overline{CS}$	$\overline{RAS}$	$\overline{CAS}$	$\overline{WE}$	DQM	BA0,1	A10/AP	A11, A9 ~ A0	Note
Register	Mode Register Set		H	X	L	L	L	L	X	OP CODE			1, 2
Refresh	Auto Refresh		H	H	L	L	L	H	X	X			3
	Self Refresh	Entry		L									3
		Exit	L	H	L	H	H	H	X	X			3
					H	X	X	X					3
Bank Active & Row Addr.			H	X	L	L	H	H	X	V	Row Address		
Read & Column Address	Auto Precharge Disable		H	X	L	H	L	H	X	V	L	Column Address (A0~A8)	4
	Auto Precharge Enable										H		4, 5
Write & Column Address	Auto Precharge Disable		H	X	L	H	L	L	X	V	L	Column Address (A0~A8)	4
	Auto Precharge Enable										H		4, 5
Burst Stop			H	X	L	H	H	L	X	X			6
Precharge	Bank Selection		H	X	L	L	H	L	X	V	L	X	
	All Banks									X	H		
Clock Suspend or Active Power Down		Entry	H	L	H	X	X	X	X	X			
					L	V	V	V					
		Exit	L	H	X	X	X	X	X				
Precharge Power Down Mode		Entry	H	L	H	X	X	X	X	X			
					L	H	H	H					
		Exit	L	H	H	X	X	X	X				
					L	V	V	V					
DQM			H	X					V	X			7
No Operation Command			H	X	H	X	X	X	X	X			
					L	H	H	H					

(V=Valid, X=Don't Care, H=Logic High, L=Logic Low)

NOTES :

1. OP Code : Operand Code
   A0 ~ A11 & BA0 ~ BA1 : Program keys. (@MRS)
2. MRS can be issued only at all banks precharge state.
   A new command can be issued after 2 CLK cycles of MRS.
3. Auto refresh functions are the same as CBR refresh of DRAM.
   The automatical precharge without row precharge command is meant by "Auto".
   Auto/self refresh can be issued only at all banks precharge state.
   Partial self refresh can be issued only after setting partial self refresh mode of EMRS.
4. BA0 ~ BA1 : Bank select addresses.
5. During burst read or write with auto precharge, new read/write command can not be issued.
   Another bank read/write command can be issued after the end of burst.
   New row active of the associated bank can be issued at tRP after the end of burst.
6. Burst stop command is valid at every burst length.
7. DQM sampled at the positive going edge of CLK masks the data-in at that same CLK in write operation (Write DQM latency is 0), but in read operation, it makes the data-out Hi-Z state after 2 CLK cycles. (Read DQM latency is 2).

A. MODE REGISTER FIELD TABLE TO PROGRAM MODES

Register Programmed with Normal MRS

Address	BA0 ~ BA1	A11 ~ A10/AP	A9*2	A8	A7	A6	A5	A4	A3	A2	A1	A0
Function	"0" Setting for Normal MRS	RFU*1	W.B.L	Test Mode		CAS Latency			BT	Burst Length		

Normal MRS Mode

Test Mode			CAS Latency				Burst Type			Burst Length				
A8	A7	Type	A6	A5	A4	Latency	A3	Type		A2	A1	A0	BT=0	BT=1
0	0	Mode Register Set	0	0	0	Reserved	0	Sequential		0	0	0	1	1
0	1	Reserved	0	0	1	1	1	Interleave		0	0	1	2	2
1	0	Reserved	0	1	0	2	Mode Select			0	1	0	4	4
1	1	Reserved	0	1	1	3	BA1	BA0	Mode	0	1	1	8	8
Write Burst Length			1	0	0	Reserved	0	0	Setting for Normal MRS	1	0	0	Reserved	Reserved
A9	Length		1	0	1	Reserved				1	0	1	Reserved	Reserved
0	Burst		1	1	0	Reserved				1	1	0	Reserved	Reserved
1	Single Bit		1	1	1	Reserved				1	1	1	Full Page*3	Reserved

Register Programmed with Extended MRS

Address	BA1	BA0	A11 ~ A10/AP	A9	A8	A7	A6	A5	A4	A3	A2	A1	A0
Function	Mode Select		RFU*1						RFU*1		PASR		

EMRS for PASR(Partial Array Self Ref.)

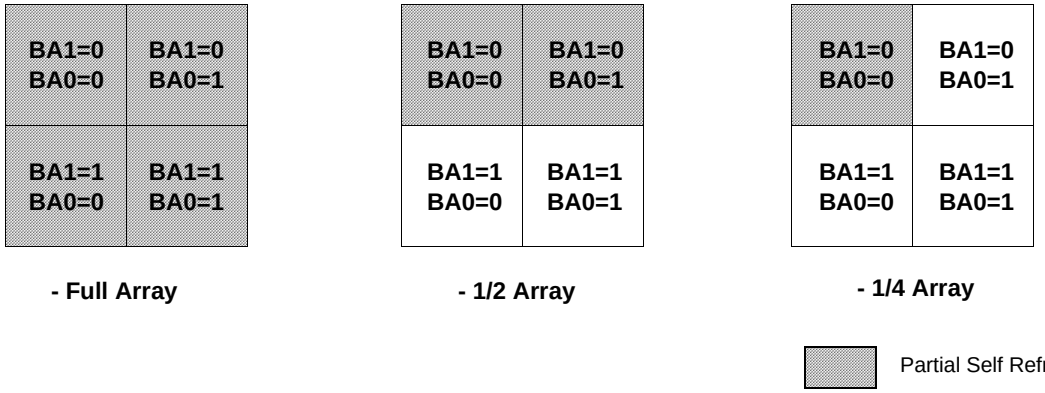
Mode Select			PASR			
BA1	BA0	Mode	A2	A1	A0	Size of Refreshed Array
0	0	Normal MRS	0	0	0	Full Array
0	1	Reserved	0	0	1	1/2 of Full Array
1	0	EMRS for Mobile SDRAM	0	1	0	1/4 of Full Array
1	1	Reserved	0	1	1	Reserved
Reserved Address			1	0	0	Reserved
A11~A10/AP	A9	A8 A7 A6 A5 A4 A3	1	0	1	Reserved
0	0	0 0 0 0 0 0	1	1	0	Reserved
			1	1	1	Reserved

NOTES:

1. RFU(Reserved for future use) should stay "0" during MRS cycle.
2. If A9 is high during MRS cycle, "Burst Read Single Bit Write" function will be enabled.
3. Full Page Length : x32 : 64Mb(256) , 128Mb (256), 256Mb (512), 512Mb (512)

Partial Array Self Refresh

1. In order to save power consumption, Mobile SDRAM has PASR option.
2. Mobile SDRAM supports 3 kinds of PASR in self refresh mode : Full Array, 1/2 of Full Array and 1/4 of Full Array.



Temperature Compensated Self Refresh

1. In order to save power consumption, Mobile-DRAM includes the internal temperature sonsor and control units to control the self refresh cycle automatically according to the two temperature range : Max 40 °C and Max 85 °C(for Extended), Max 70 °C(for Commercial).
2. If the EMRS for external TCSR is issued by the controller, this EMRS code for TCSR is ginored.

Temperature Range	Self Refresh Current (Icc6)					Unit
	- E/C	- N/L	- G/F			
			Full Array	1/2 of Full Array	1/4 of Full Array	
Max 85/70 °C	1500	600	600	450	400	uA
Max 40 °C			450	400	350	

B. POWER UP SEQUENCE

1. Apply power and attempt to maintain CKE at a high state and all other inputs may be undefined.
   - Apply VDD before or at the same time as VDDQ.
2. Maintain stable power, stable clock and NOP input condition for a minimum of 200us.
3. Issue precharge commands for all banks of the devices.
4. Issue 2 or more auto-refresh commands.
5. Issue a mode register set command to initialize the mode register.
6. Issue a extended mode register set command to define PASR operating type of the device after normal MRS.

EMRS cycle is not mandatory and the EMRS command needs to be issued only when PASR is used.
The default state without EMRS command issued is all full array refreshed.
The device is now ready for the operation selected by EMRS.
For operating with PASR, set PASR mode in EMRS setting stage.
In order to adjust another mode in the state of PASR mode, additional EMRS set is required but power up sequence is not needed again at this time. In that case, all banks have to be in idle state prior to adjusting EMRS set.

C. BURST SEQUENCE

1. BURST LENGTH = 4

Initial Address		Sequential				Interleave			
A1	A0								
0	0	0	1	2	3	0	1	2	3
0	1	1	2	3	0	1	0	3	2
1	0	2	3	0	1	2	3	0	1
1	1	3	0	1	2	3	2	1	0

2. BURST LENGTH = 8

Initial Address			Sequential								Interleave							
A2	A1	A0																
0	0	0	0	1	2	3	4	5	6	7	0	1	2	3	4	5	6	7
0	0	1	1	2	3	4	5	6	7	0	1	0	3	2	5	4	7	6
0	1	0	2	3	4	5	6	7	0	1	2	3	0	1	6	7	4	5
0	1	1	3	4	5	6	7	0	1	2	3	2	1	0	7	6	5	4
1	0	0	4	5	6	7	0	1	2	3	4	5	6	7	0	1	2	3
1	0	1	5	6	7	0	1	2	3	4	5	4	7	6	1	0	3	2
1	1	0	6	7	0	1	2	3	4	5	6	7	4	5	2	3	0	1
1	1	1	7	0	1	2	3	4	5	6	7	6	5	4	3	2	1	0